

半導體超微量分析中心

Ultra Trace Analysis Service Center of Semiconductor

日期: 2022年10月03日

頁數:1 of 2

測試報告

報告編號: DNS22900195

程陽有限公司

新北市新莊區復興路三段109號

以下測試之樣品係由申請廠商所提供及確認:

產品名稱: 貼霸

申請廠商: 程陽有限公司 收樣日期: 2022年09月13日

測試日期: 2022年09月13日~2022年10月03日

測試結果:

| 測試項目 | 測試方法 | 測試結果 | | | | 定量/偵測 | 單位 |
|-------------|---------------------|--------|--------|--------|--------|--------|--------|
| | | 001 | 002 | 003 | 平均 | 極限 | 平征 |
| 總質量損失 | 本測試參考ASTM E595-15方法 | 0.584 | 0.575 | 0.580 | 0.580 | 0.0100 | %(w/w) |
| | ,以微量電子天平檢測。 | | | | | | |
| 收集的揮發性可冷凝物質 | 1 | 0.357 | 0.293 | 0.297 | 0.316 | 0.0100 | %(w/w) |
| | | | | | | | |
| 逸散之水蒸氣 | 1 | 0.0769 | 0.0809 | 0.0769 | 0.0782 | 0.0100 | %(w/w) |
| | | | | | | | |

供計

- 1. 測試報告僅就委託者之委託事項提供測試結果,不對產品合法性做判斷。
- 2. 本報告不得分離,分離使用無效。
- 3. 若該測試項目屬於定量分析則以「定量極限」表示;若該測試項目屬於定性分析則以「偵測極限」表示。
- 4. 低於定量極限/偵測極限之測定值以 "N. D. "或" 陰性 "表示。微生物測試低於定量極限以"<定量極限值"表示。
- 5. 本測試結果為樣品狀態偏離(混合測試)之情況下所得。

- END -



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Member of the SGS Group



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樣品照片

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